## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | EDIC ET AL. | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,187,745 B2	03-2007	Flohr et al.	378/8
*	В	US-7,142,703 B2	11-2006	Kaufman et al.	382/131
*	C	US-7,085,342 B2	08-2006	Younis et al.	378/8
*	D	US-7,058,440 B2	06-2006	Heuscher et al.	600/428
*	Е	US-6,526,117 B1	02-2003	Okerlund et al.	378/8
*	F	US-6,510,337 B1	01-2003	Heuscher et al.	600/428
*	G	US-6,381,487 B1	04-2002	Flohr et al.	600/425
*	Ι	US-6,154,516	11-2000	Heuscher et al.	378/15
	-	US-			
	J	US-			
	K	US-			
	L	US-			
_	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.